Features

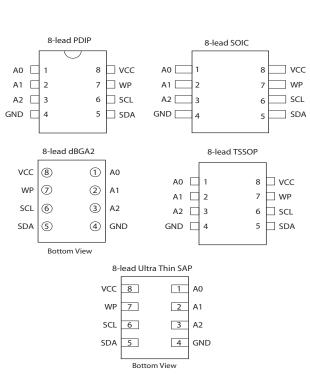
- Low-voltage and Standard-voltage Operation
 - 1.8 (V_{CC} = 1.8V to 5.5V)
- Internally Organized as 32,768 x 8
- Two-wire Serial Interface
- Schmitt Trigger, Filtered Inputs for Noise Suppression
- Bidirectional Data Transfer Protocol
- 1 MHz (5.0V, 2.7V, 2.5V), and 400 kHz (1.8V) Compatibility
- Write Protect Pin for Hardware and Software Data Protection
- 64-byte Page Write Mode (Partial Page Writes Allowed)
- Self-timed Write Cycle (5 ms Max)
- High Reliability
 - Endurance: One Million Write Cycles
 - Data Retention: 40 Years
- Lead-free/Halogen-free Devices Available
- 8-lead JEDEC PDIP, 8-lead JEDEC SOIC, EIAJ SOIC, 8-lead Ultra Thin Small Array Package (SAP), 8-lead TSSOP, and 8-ball dBGA2 Packages
- Die Sales: Wafer Form, Waffle Pack and Bumped Wafers

Description

The AT24C256B provides 262,144 bits of serial electrically erasable and programmable read-only memory (EEPROM) organized as 32,768 words of 8 bits each. The device's cascadable feature allows up to eight devices to share a common two-wire bus. The device is optimized for use in many industrial and commercial applications where low-power and low-voltage operation are essential. The devices are available in space-saving 8-lead JEDEC PDIP, 8-lead JEDEC SOIC, 8-lead Ultra Thin SAP, 8lead TSSOP, and 8-ball dBGA2 packages. In addition, the entire family is available in a 1.8V (1.8V to 5.5V) version.

Pin Configurations

		_
Pin Name	Function	
A0-A2	Address Inputs	
SDA	Serial Data	
SCL	Serial Clock Input	
WP	Write Protect	
GND	Ground	





Two-wire Serial EEPROM

256K (32,768 x 8)

AT24C256B





1. Absolute Maximum Ratings*

Operating Temperature 55°C to +125°C	;
Storage Temperature 65°C to +150°C)
Voltage on Any Pin with Respect to Ground – 1.0V to +7.0V	/
Maximum Operating Voltage 6.25V	/
DC Output Current 5.0 mA	٩

*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

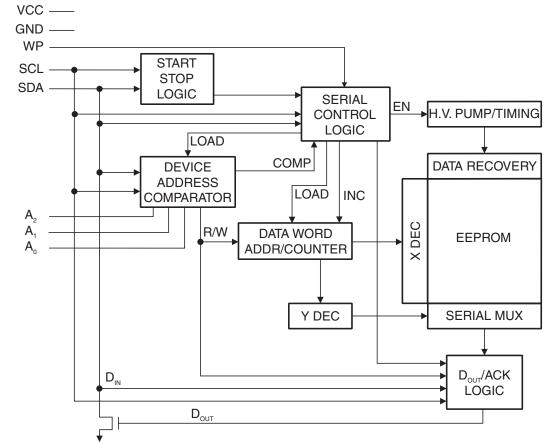


Figure 1-1. Block Diagram

2. Pin Description

SERIAL CLOCK (SCL): The SCL input is used to positive-edge clock data into each EEPROM device and negative-edge clock data out of each device.

SERIAL DATA (SDA): The SDA pin is bidirectional for serial data transfer. This pin is opendrain driven and may be wire-ORed with any number of other open-drain or open-collector devices.

DEVICE/PAGE ADDRESSES (A2, A1, A0): The A2, A1, and A0 pins are device address inputs that are hardwired (directly to GND or to Vcc) for compatibility with other AT24Cxx devices. When the pins are hardwired, as many as eight 256K devices may be addressed on a single bus system. (Device addressing is discussed in detail under "Device Addressing," page 9.) A device is selected when a corresponding hardware and software match is true. If these pins are left floating, the A2, A1, and A0 pins will be internally pulled down to GND. However, due to capacitive coupling that may appear during customer applications, Atmel recommends always connecting the address pins to a known state. When using a pull-up resistor, Atmel recommends using $10k\Omega$ or less.

WRITE PROTECT (WP): The write protect input, when connected to GND, allows normal write operations. When WP is connected directly to Vcc, all write operations to the memory are inhibited. If the pin is left floating, the WP pin will be internally pulled down to GND. However, due to capacitive coupling that may appear during customer applications, Atmel recommends always connecting the WP pins to a known state. When using a pull-up resistor, Atmel recommends using $10k\Omega$ or less.

3. Memory Organization

AT24C256B, 256K SERIAL EEPROM: The 256K is internally organized as 512 pages of 64 bytes each. Random word addressing requires a 15-bit data word address.

Table 3-1.Pin Capacitance⁽¹⁾

Applicable over recommended operating range from $T_A = 25^{\circ}C$, f = 1.0 MHz, $V_{CC} = +1.8V$

Symbol	Test Condition	Max	Units	Conditions
C _{I/O}	Input/Output Capacitance (SDA)	8	pF	V _{I/O} = 0V
C _{IN}	Input Capacitance (A ₀ , A ₁ , SCL)	6	pF	$V_{IN} = 0V$

Note: 1. This parameter is characterized and is not 100% tested.





Table 3-2.DC Characteristics

Applicable over recommended operating range from: $T_{AI} = -40^{\circ}C$ to +85°C, $V_{CC} = +1.8V$ to +5.5V (unless otherwise noted)

Symbol	Parameter	Test Condition	1	Min	Тур	Max	Units
V _{CC1}	Supply Voltage			1.8		5.5	V
I _{CC1}	Supply Current	V _{CC} = 5.0V	READ at 400 kHz		1.0	2.0	mA
I _{CC2}	Supply Current	V _{CC} = 5.0V	WRITE at 400 kHz		2.0	3.0	mA
	Standby Current	V _{CC} = 1.8V				1.0	μA
I _{SB1}	(1.8V option)	V _{CC} = 5.0V	$V_{\rm IN} = V_{\rm CC} \text{ or } V_{\rm SS}$			6.0	μA
I _{LI}	Input Leakage Current V _{CC} = 5.0V	$V_{IN} = V_{CC} \text{ or } V_{SI}$	S		0.10	3.0	μA
I _{LO}	Output Leakage Current V _{CC} = 5.0V	$V_{OUT} = V_{CC} \text{ or } V_{SS}$			0.05	3.0	μA
V _{IL}	Input Low Level ⁽¹⁾			- 0.6		V _{CC} x 0.3	V
V _{IH}	Input High Level ⁽¹⁾			V _{CC} x 0.7		V _{CC} + 0.5	V
V _{OL2}	Output Low Level	V _{CC} = 3.0V	I _{OL} = 2.1 mA			0.4	V
V _{OL1}	Output Low Level	V _{CC} = 1.8V	I _{OL} = 0.15 mA			0.2	V

Notes: 1. V_{IL} min and V_{IH} max are reference only and are not tested.

AT24C256B

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Table 3-3. AC Characteristics (Industrial Temperature)

Applicable over recommended operating range from $T_{AI} = -40^{\circ}$ C to +85°C, $V_{CC} = +1.8$ V to +5.5V, CL = 100 pF (unless otherwise noted). Test conditions are listed in Note 2.

		1.	.8-volt	2.5,	5.0-volt	
Symbol	Parameter	Min	Max	Min	Max	Units
f _{SCL}	Clock Frequency, SCL		400		1000	kHz
t _{LOW}	Clock Pulse Width Low	1.3		0.4		μs
t _{HIGH}	Clock Pulse Width High	0.6		0.4		μs
t _i	Noise Suppression Time ⁽¹⁾		100		50	ns
t _{AA}	Clock Low to Data Out Valid	0.05	0.9	0.05	0.55	μs
t _{BUF}	Time the bus must be free before a new transmission can start ⁽¹⁾	1.3		0.5		μs
t _{HD.STA}	Start Hold Time	0.6		0.25		μs
t _{SU.STA}	Start Set-up Time	0.6		0.25		μs
t _{HD.DAT}	Data In Hold Time	0		0		μs
t _{SU.DAT}	Data In Set-up Time	100		100		ns
t _R	Inputs Rise Time ⁽¹⁾		0.3		0.3	μs
t _F	Inputs Fall Time ⁽¹⁾		300		100	ns
t _{SU.STO}	Stop Set-up Time	0.6		0.25		μs
t _{DH}	Data Out Hold Time	50		50		ns
t _{WR}	Write Cycle Time		5		5	ms
Endurance ⁽¹⁾	25°C, Page Mode, 3.3V	1,000,000		Write Cycles		

Notes: 1. This parameter is ensured by characterization and is not 100% tested.

2. AC measurement conditions: $R_L \text{ (connects to V}_{CC}\text{): } 1.3 \text{ k}\Omega \text{ (2.5V, 5.5V), } 10 \text{ k}\Omega \text{ (1.8V)}$ Input pulse voltages: 0.3 V_{CC} to 0.7 V_{CC} Input rise and fall times: $\leq 50 \text{ ns}$ Input and output timing reference voltages: 0.5 V_{CC}



8. AT24C256B Ordering Codes

Ordering Code	Voltage	Package	Operation Range
AT24C256B-PU (Bulk Form Only)	1.8	8P3	
AT24C256BN-SH-B ⁽¹⁾ (NiPdAu Lead Finish)	1.8	8S1	
AT24C256BN-SH-T ⁽²⁾ (NiPdAu Lead Finish)	1.8	8S1	
AT24C256BW-SH-B ⁽¹⁾ (NiPdAu Lead Finish)	1.8	8S2	Lead-free/Halogen-free
AT24C256BW-SH-T ⁽²⁾ (NiPdAu Lead Finish)	1.8	8S2	Industrial Temperature
AT24C256B-TH-B ⁽¹⁾ (NiPdAu Lead Finish)	1.8	8A2	(−40°C to 85°C)
AT24C256B-TH-T ⁽²⁾ (NiPdAu Lead Finish)	1.8	8A2	
AT24C256BY7-YH-T ⁽²⁾ (NiPdAu Lead Finish)	1.8	8Y7	
AT24C256BU2-UU-T ⁽²⁾	1.8	8U2-1	
	1.0	Dia Cala	Industrial Temperature
AT24C256B-W-11	1.8	Die Sale	(–40°C to 85°C)

Notes: 1. "-B" denotes bulk.

2. "-T" denotes tape and reel. SOIC = 4K per reel. TSSOP and dBGA2 = 5K per reel. SAP = 3K per reel. EIAJ = 2K per reel.

3. Available in tape & reel and wafer form; order as SL788 for inkless wafer form. Bumped die available upon request. Please contact Serial Interface Marketing.

	Package Type			
8P3	8-lead, 0.300" Wide, Plastic Dual Inline Package (PDIP)			
8S1	8-lead, 0.150" Wide, Plastic Gull Wing Small Outline Package (JEDEC SOIC)			
8S2	8-lead, 0.200" Wide, Plastic Gull Wing Small Outline Package (EIAJ SOIC)			
8U2-1	8-ball, die Ball Grid Array Package (dBGA2)			
8A2	8-lead, 4.40 mm Body, Plastic Thin Shrink Small Outline Package (TSSOP)			
8Y7	8-lead, 6.00 mm x 4.90 mm Body, Ultra Thin, Dual Footprint, Non-leaded, Small Array Package (SAP)			
	Options			
-1.8	Low-voltage (1.8V to 5.5V)			





8S1 – JEDEC SOIC

